

**Search Notes****Application/Control No.**

09/016,159

**Examiner**

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**Applicant(s)/Patent under Reexamination**

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**Art Unit**

1647

**SEARCHED**

Class	Subclass	Date	Examiner
530	350	12/1/1998	DF
435	7.1	12/1/1998	DF
UPDATED	SEARCH	9/24/2002	FH
UPDATED	SEARCH	4/7/2003	FH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed parent application	12/1/1998	DF
WEST, US PATENT FULL.	5/3/2004	FH
STN-VIA MEDLINE, CAPLUS, BIOSIS, EMBASE	3/11/2003	FH
SEQ ID NO:5	4/22/2005	FH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
530	350	12/1/2005	FH
435	7.1	12/1/2005	FH
SEQ ID NO:4, 5		4/22/2005	FH